MOSFET - N-Channel, POWERTRENCH®

100 V, 164 A, 4.5 m Ω

Description

This N-Channel MOSFET is produced using ON Semiconductor's advance POWERTRENCH process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

Features

- $R_{DS(on)} = 3.8 \text{ m}\Omega \text{ (Typ.)} @ V_{GS} = 10 \text{ V}, I_D = 100 \text{ A}$
- Fast Switching Speed
- Low Gate Charge, $Q_G = 54 \text{ nC}$ (Typ.)
- High Performance Trench Technology for Extremely Low R_{DS(on)}
- High Power and Current Handling Capability
- This Device is Pb-Free and is RoHS Compliant

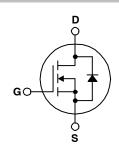
Applications

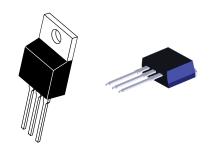
- Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection Circuit
- Motor Drives and Uninterruptible Power Supplies
- Micro Solar Inverter



ON Semiconductor®

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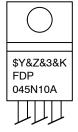


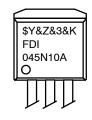


TO-220 CASE 221A-09

I²PAK CASE 418AV

MARKING DIAGRAM





\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Numeric Date Code &K = Lot Code

FDP/FDI045N10A = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

MOSFET MAXIMUM RATINGS ($T_C = 25^{\circ}C$ Unless Otherwise Noted)

| Symbol | | Parameter | FDP045N10A_F102 FDI045N10A_F102 | Unit |
|-----------------------------------|---------------------------|---|------------------------------------|------|
| V_{DSS} | Drain to Source Voltage | | 100 | V |
| V _{GSS} | Gate to Source Voltage | | ±20 | V |
| I _D | Drain Current | - Continuous (T _C = 25°C, Silicon Limited) | 164* | Α |
| | | Continuous (T_C = 100°C, Silicon LImited) | | 1 |
| | | Continuous (T_C = 25°C, Package Limited) | 120 | |
| I _{DM} | Drain Current | - Pulsed (Note 1) | 656 | Α |
| E _{AS} | Single Pulsed Avalanche E | Energy (Note 2) | 637 | mJ |
| dv/dt | Peak Diode Recovery dv/d | It (Note 3) | 6.0 | V/ns |
| P_{D} | Power Dissipation | (T _C = 25°C) | 263 | W |
| | − Derate Above 25°C | | 1.75 | W/°C |
| T _J , T _{STG} | Operating and Storage Ter | Operating and Storage Temperature Range | | °C |
| TL | Maximum Lead Temperatu | re for Soldering, 1/8" from Case for 5 Seconds | 300 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

*Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 120 A.

THERMAL CHARACTERISTICS

| Symbol | | FDP045N10A_F102 FDI045N10A_F102 | |
|--------|---|------------------------------------|----|
| Rejc | Thermal Resistance, Junction to Case, Max. | 0.57 | °C |
| ReJA | Thermal Resistance, Junction to Ambient, Max. | 62.5 | |

PACKAGE MARKING AND ORDERING INFORMATION

| | Part Number | Top Mark | Package | Packing Method | Reel Size | Tape Width | Quantity |
|---|-----------------|------------|---------------------|----------------|-----------|------------|----------|
| Ī | FDP045N10A_F102 | FDP045N10A | TO-220 | Tube | N/A | N/A | 50 Units |
| Ī | FDI045N10A_F102 | FDI045N10A | I ² -PAK | Tube | N/A | N/A | 50 Units |

ELECTRICAL CHARACTERISTICS (T_C = 25°C Unless Otherwise Noted)

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|------------------------------------|--|---|------|------|------|------|
| OFF CHAR | ACTERISTICS | • | | | • | |
| BV _{DSS} | Drain to Source Breakdown Voltage | I _D = 250 mA, V _{GS} = 0 V | 100 | - | _ | V |
| $\Delta BV_{DSS} \ / \Delta T_{J}$ | Breakdown Voltage Temperature Coefficient | I _D = 250 mA, Referenced to 25°C | - | 0.07 | - | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 80 V, V _{GS} = 0 V | - | - | 1 | μΑ |
| | | V _{DS} = 80 V, T _C = 150°C | - | - | 500 | |
| I _{GSS} | Gate to Body Leakage Current | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ | - | - | ±100 | nA |
| ON CHARA | CTERISTICS | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{GS} = V_{DS}$, $I_D = 250 \text{ mA}$ | 2.0 | - | 4.0 | V |
| R _{DS(on)} | Static Drain to Source On Resistance | V _{GS} = 10 V, I _D = 100 A | - | 3.8 | 4.5 | mΩ |
| 9FS | Forward Transconductance | V _{DS} = 10 V, I _D = 100 A | _ | 132 | _ | S |

ELECTRICAL CHARACTERISTICS (T_C = 25°C Unless Otherwise Noted) (continued)

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|----------------------|--|---|------|------|------|------|
| YNAMIC | CHARACTERISTICS | | • | | | • |
| C _{iss} | Input Capacitance | V _{DS} = 50 V, V _{GS} = 0 V | _ | 3960 | 5270 | pF |
| C _{oss} | Output Capacitance | f = 1 MHz | _ | 925 | 1230 | pF |
| C _{rss} | Reverse Transfer Capacitance | | _ | 34 | _ | pF |
| C _{oss(er)} | Engry Releted Output Capacitance | V _{DS} = 50 V, V _{GS} = 0 V | - | 1520 | - | pF |
| Q _{g(tot)} | Total Gate Charge at 10V | V _{GS} = 10 V, V _{DS} = 50 V, | - | 54 | 74 | nC |
| Q _{gs} | Gate to Source Gate Charge | I _D = 100 A (Note 4) | _ | 17 | _ | nC |
| Q _{gs2} | Gate Charge Threshold to Plateau | (14010 4) | _ | 8 | _ | nC |
| Q _{gd} | Gate to Drain "Miller" Charge | | _ | 13 | _ | nC |
| ESR | Equivalent Series Resistance (G-S) | f = 1 MHz | _ | 1.9 | - | Ω |
| WITCHING | G CHARACTERISTICS | • | • | • | | |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = 50 \text{ V}, I_D = 100 \text{ A},$ | _ | 23 | 56 | ns |
| t _r | Turn-On Rise Time | $V_{GS} = 10 \text{ V}, R_{G} = 4.7 \Omega$ (Note 4) | - | 26 | 62 | ns |
| t _{d(off)} | Turn-Off Delay Time | (14010 4) | _ | 50 | 110 | ns |
| t _f | Turn-Off Fall Time | | _ | 15 | 40 | ns |
| RAIN-SO | URCE DIODE CHARACTERISTICS | | | | | |
| I _S | Maximum Continuous Drain to Source Diode | Forward Current | - | - | 164* | Α |
| I _{SM} | Maximum Pulsed Drain to Source Diode Forward Current | | - | - | 656 | Α |
| V_{SD} | Drain to Source Diode Forward Voltage | V _{GS} = 0 V, I _{SD} = 100 A | _ | | 1.3 | V |
| t _{rr} | Reverse Recovery Time | $V_{GS} = 0 \text{ V}, V_{DD} = 50 \text{ V},$ $I_{SD} = 100 \text{ A},$ | - | 75 | - | ns |
| Q _{rr} | Reverse Recovery Charge | $dl_F/dt = 100 \text{ A/ms}$ | _ | 120 | - | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics for the listed test conditions.

1. Repetitive rating: pulse–width limited by maximum junction temperature.

2. L = 3 mH, I_{AS} = 20.6 A, R_{G} = 25 Ω , starting T_{J} = 25°C.

3. $I_{SD} \le 100$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le BV_{DSS}$, starting T_{J} = 25°C.

4. Essentially independent of operating temperature typical characteristics.

IS, Reverse Drain Current [A]

V_{GS}, Gate-Source Voltage [V]

TYPICAL PERFORMANCE CHARACTERISTICS

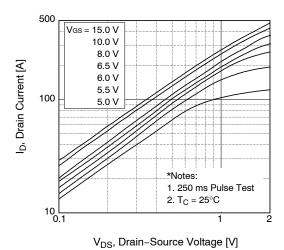


Figure 1. On-Region Characteristics

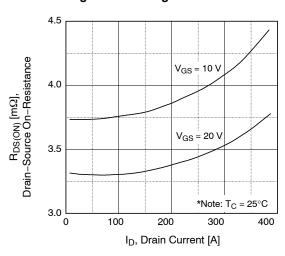


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

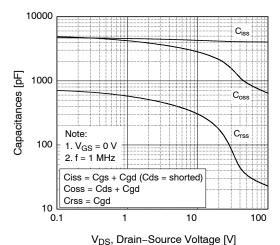


Figure 5. Capacitance Characteristics

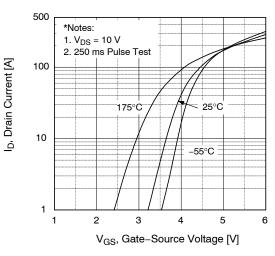


Figure 2. Transfer Characteristics

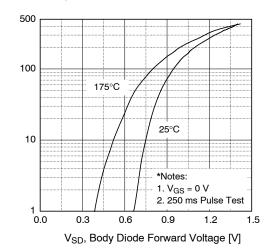


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

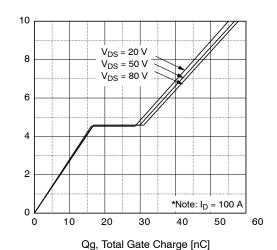


Figure 6. Gate Charge Characteristics

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

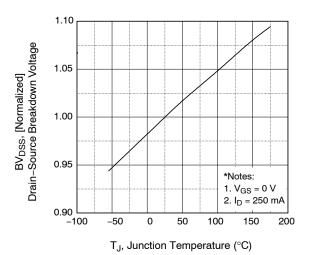


Figure 7. Maximum Safe Operating Area

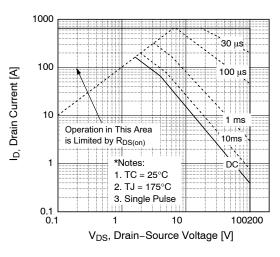


Figure 9. Maximum Safe Operating Area

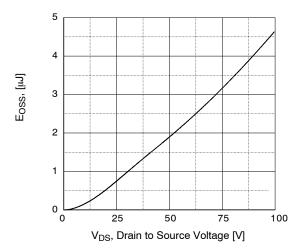


Figure 11. Eoss vs. Drain to Source Voltage

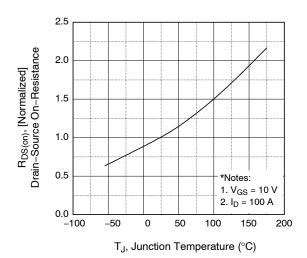


Figure 8. On–Resistance Variation vs.
Temperature

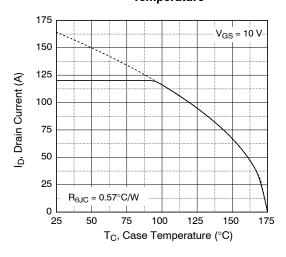


Figure 10. Maximum Drain Current vs. Case Temperature

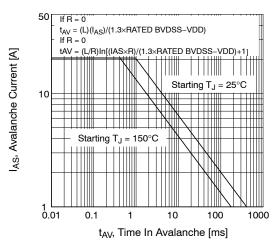


Figure 12. Unclamped Inductive Switching Capability

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

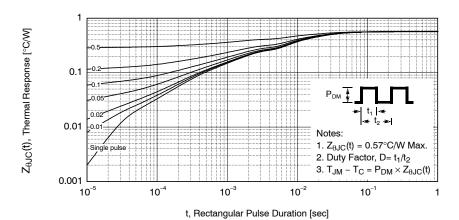


Figure 13. Transient Thermal Response Curve

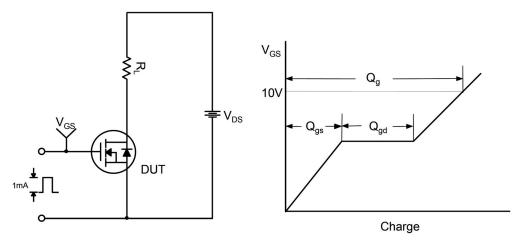


Figure 14. Gate Charge Test Circuit & Waveform

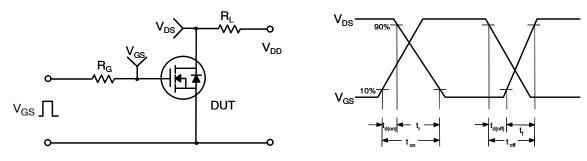


Figure 15. Resistive Switching Test Circuit & Waveforms

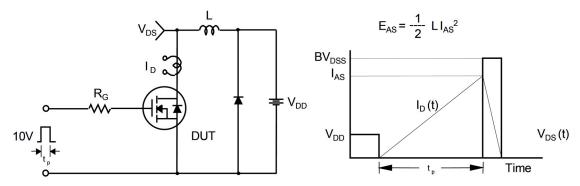
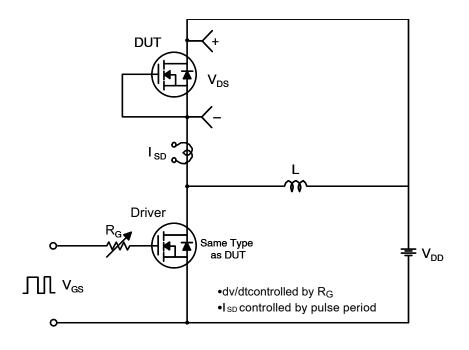


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms



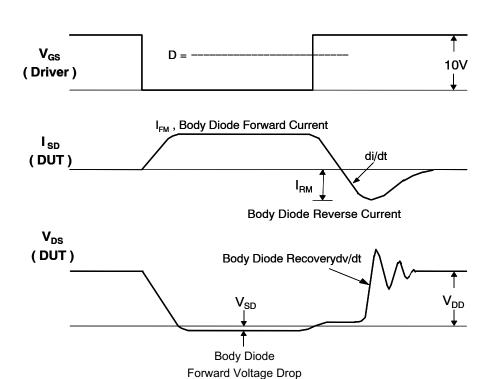
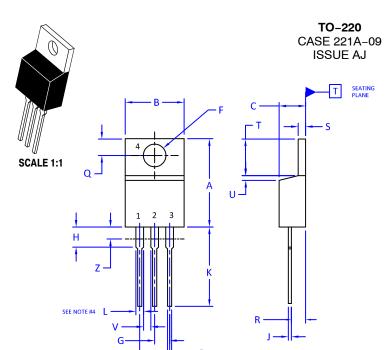


Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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DATE 05 NOV 2019

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: INCHES
- 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

4. MAX WIDTH FOR F102 DEVICE = 1.35MM

| | INCHES | | MILLIMI | ETERS |
|-----|--------|-------|---------|-------|
| DIM | MIN. | MAX. | MIN. | MAX. |
| Α | 0.570 | 0.620 | 14.48 | 15.75 |
| В | 0.380 | 0.415 | 9.66 | 10.53 |
| С | 0.160 | 0.190 | 4.07 | 4.83 |
| D | 0.025 | 0.038 | 0.64 | 0.96 |
| F | 0.142 | 0.161 | 3.60 | 4.09 |
| G | 0.095 | 0.105 | 2.42 | 2.66 |
| Н | 0.110 | 0.161 | 2.80 | 4.10 |
| J | 0.014 | 0.024 | 0.36 | 0.61 |
| К | 0.500 | 0.562 | 12.70 | 14.27 |
| L | 0.045 | 0.060 | 1.15 | 1.52 |
| N | 0.190 | 0.210 | 4.83 | 5.33 |
| Q | 0.100 | 0.120 | 2.54 | 3.04 |
| R | 0.080 | 0.110 | 2.04 | 2.79 |
| S | 0.045 | 0.055 | 1.15 | 1.41 |
| Т | 0.235 | 0.255 | 5.97 | 6.47 |
| U | 0.000 | 0.050 | 0.00 | 1.27 |
| V | 0.045 | | 1.15 | |
| Z | | 0.080 | | 2.04 |

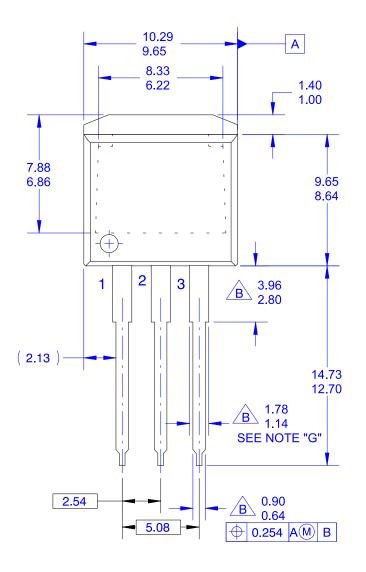
| STYLE 1: | | STYLE 2: | | STYLE 3: | | STYLE 4: | |
|----------|-----------|-----------|-----------|-----------|---------|----------|--------------------|
| PIN 1. | BASE | PIN 1. | BASE | PIN 1. | CATHODE | PIN 1. | MAIN TERMINAL 1 |
| 2. | COLLECTOR | 2. | EMITTER | 2. | ANODE | 2. | MAIN TERMINAL 2 |
| 3. | EMITTER | 3. | COLLECTOR | 3. | GATE | 3. | GATE |
| 4. | COLLECTOR | 4. | EMITTER | 4. | ANODE | 4. | MAIN TERMINAL 2 |
| STYLE 5: | | STYLE 6: | | STYLE 7: | | STYLE 8: | |
| PIN 1. | GATE | PIN 1. | ANODE | PIN 1. | CATHODE | PIN 1. | CATHODE |
| 2. | DRAIN | 2. | CATHODE | 2. | ANODE | 2. | ANODE |
| 3. | SOURCE | 3. | ANODE | 3. | CATHODE | 3. | EXTERNAL TRIP/DELA |
| 4. | DRAIN | 4. | CATHODE | 4. | ANODE | 4. | ANODE |
| STYLE 9: | | STYLE 10: | | STYLE 11: | | STYLE 12 | : |
| PIN 1. | GATE | PIN 1. | GATE | PIN 1. | DRAIN | PIN 1. | MAIN TERMINAL 1 |
| 2. | COLLECTOR | 2. | SOURCE | 2. | SOURCE | 2. | MAIN TERMINAL 2 |
| 3. | EMITTER | 3. | DRAIN | 3. | GATE | 3. | GATE |
| 4. | COLLECTOR | 4. | SOURCE | 4. | SOURCE | 4. | NOT CONNECTED |
| | | | | | | | |

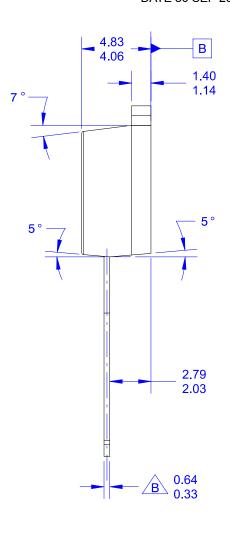
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12PAK (TO-262 3 LD) CASE 418AV **ISSUE O**

DATE 30 SEP 2016





NOTES:

A. EXCEPT WHERE NOTED CONFORMS TO
TO262 JEDEC VARIATION AA.
B DOES NOT COMPLY JEDEC STD. VALUE.
C. ALL DIMENSIONS ARE IN MILLIMETERS.
D. DIMENSIONS ARE EXCLUSIVE OF BURRS,
MOLD FLASH AND TIE BAR PRETRUSIONS.

E. DIMENSION AND TOLERANCE AS PER ANSI

Y14.5-1994.

F. LOCATION OF PIN HOLE MAY VARY

(LOWER LEFT CORNER, LOWER CENTER AND CENTER OF PACKAGE)

G. MAXIMUM WIDTH FOR F102 DEVICE = 1.35 MAX.

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